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Photoluminescent properties of yellow emitting $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ phosphors for white light-emitting diodes

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Abstract

 $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ phosphors with Eu^{2+} concentration (x) in the range of 0–0.25 are synthesized by solid-state reaction. With increasing x, the energy dispersive spectra show that the O/N ratio increases from 0.54 to 1.43 and the emission and excitation spectra show a redshift due to increased splitting of the low-lying 4f⁶5d¹ state of Eu²⁺. An additional excitation band appears at around 460 nm for high doping concentrations of Eu²⁺, perfectly matching the emission wavelength of blue light-emitting diodes (LEDs). The phosphors can be excited in the near-UV to blue region to emit a broad yellow band in the range 543–562 nm, which depends on x. A white LED is fabricated by combining the Ca_{0.85}Eu_{0.15}Si₂O_{2-\delta}N_{2+2\delta/3} phosphor with a blue GaN chip. Under 20 mA forward-bias current, a CIE chromaticity coordinate of (0.3396, 0.3474), the corresponding colour temperature (T_c) of 5223 K, the colour rendering index of 74 and luminous efficiency of 20 lm W⁻¹ are obtained.

1. Introduction

Since the realization of GaN based blue light-emitting diodes (LEDs) [1,2], white LEDs have been paid much attention for the new generation solid-state lighting. Compared with conventional incandescent and fluorescent lamps, the white LEDs are superior in lifetime, efficiency and reliability, which promises significant reductions in power consumption and in pollution from fossil fuel power plants [3-6]. There are alternative ways to generate white light: the first approach is to mix the light of different colours emitted from different LED chips. Another approach is to mix the emission from a blue or near-UV LED chip with a longer wavelength light down-converted from the LED emission using phosphors [7-11]. Nowadays, the mainstream white LED lamp is a combination of a blue LED semiconductor die and a trivalent cerium activated yttrium-aluminum-garnet $(YAG: Ce^{3+})$ yellow phosphor [12, 13]. Yellow is the complementary colour of blue, so a mixture of blue light and vellow light exhibits white light [14]. Therefore, the phosphor plays an important role in white-light LED. In the case of white LED phosphors, the inorganic phosphors attract much more attention due to their high luminescent efficiency and long lifetime [15]. But there are very few inorganic vellow phosphors which can combine with a blue chip. The currently commercial yellow phosphor materials for white LED are YAG : Ce^{3+} and Sr_3SiO_5 : Eu^{2+} , but YAG : Ce^{3+} shows a high thermal quenching [16] and $Sr_3SiO_5:Eu^{2+}$ shows a poor colour rendition index (CRI = 64) [17]. In recent years, some new yellow emitting oxynitride phosphors such as Ca- α -SiAlON: Eu²⁺ and CaSi₂O₂N₂: Eu²⁺ have been invented. Though Ca- α -SiAlON : Eu²⁺ phosphors have attracted much attention because of their outstanding properties, these kinds of phosphors are prepared at quite high temperature (1800 °C), high pressure (0.925 MPa) and nitridation conditions [18], which are difficult to carry out. In contrast, the $CaSi_2O_2N_2$: Eu²⁺ phosphors only need the usual preparation conditions. Li et al reported luminescent properties of

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 $MSi_2O_{2-\delta}N_{2+2\delta/3}$: Eu^{2+} (M = Ca, Sr, Ba) and suggested that the composition of $CaSi_2O_{2-\delta}N_{2+2\delta/3}$: Eu^{2+} may be somewhat more nitrogen rich than $CaSi_2O_2N_2$: $Eu^{2+}(\delta = 0)$, that is, $\delta > 0$.

 $CaSi_2O_{2-\delta}N_{2+2\delta/3}$: Eu^{2+} phosphors can effectively offset the defects of traditional phosphors for white LEDs due to their outstanding properties such as high thermal stability and chemical stability [16]. In particular, they can absorb in the near-UV to blue region and cover a broad section of the colour spectrum, which demonstrate their better luminescent properties and the possibility of improving the CRI of white LED. However, the effect of the Eu^{2+} concentration on the luminescence of $CaSi_2O_{2-\delta}N_{2+2\delta/3}$: Eu^{2+} has not been demonstrated.

In this paper, we report the photoluminescence (PL) properties of $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ as a function of Eu^{2+} concentrations. The $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ phosphors include both nitrogen rich, i.e. $\delta > 0$ and oxygen rich, i.e. $\delta < 0$ compositions. White LED is fabricated by combining 460 nm emitting GaN chip with $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ phosphor for x = 0.15.

2. Experimental

A series of samples, the undoped and Eu^{2+} -doped $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0-0.25) phosphors are prepared by a high-temperature solid-state reaction technique. The starting materials are CaO (analytical grade), SiO₂ (analytical grade), Si₃N₄ (analytical grade) and Eu₂O₃ (99.99%). The raw materials are taken in an agate mortar in stoichiometric molar ratio and ground for 1 h, and then the mixture is loaded into alumina crucibles and sintered at 1380 °C for 4 h in a horizontal tube furnace under a weak reductive atmosphere ($5\%H_2 + 95\%N_2$ mixed flowing gas), followed by additional grinding. The crystal structures of all the samples are checked using conventional x-ray diffraction (XRD). PL excitation (PLE) and PL spectra are measured using a fluorescent spectrophotometer (F-4500, Hitachi Ltd, Japan) equipped with a Xe lamp as an excitation source; at the same time the diffuse reflection spectra are obtained by a BaSO₄ white powder as the standard reference. The decay curves are recorded by a TDS3052 (digital phosphor) oscilloscope. The white LED is fabricated by a combination of a blue GaN chip and the prepared $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.15) phosphor. The LED spectrum is measured using a USB4000 spectrophotometer.

3. Results and discussion

3.1. XRD analysis

Figure 1 shows the powder diffraction patterns of the undoped and Eu²⁺-doped CaSi₂O_{2- δ}N_{2+2 $\delta/3}} synthesized at 1380 °C in$ a weak reductive atmosphere. The XRD patterns are collected $in the range 18° <math>\leq 2\theta \leq 60^{\circ}$. The powder diffraction patterns of Ca_{1-x}Eu_xSi₂O_{2- δ}N_{2+2 $\delta/3}} are essentially close to$ $those reported for CaSi₂O_{2-<math>\delta$}N_{2+2 $\delta/3}$ ($\delta \geq 0$) by Y Q Li and H T Hintzen. They have a monoclinic crystal structure [16]}</sub></sub>



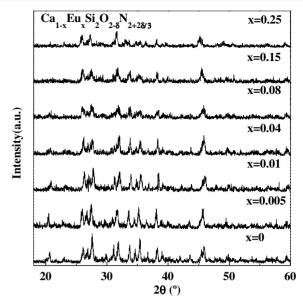


Figure 1. XRD patterns of $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (*x* = 0–0.25).

and the particle size is about $1 \mu m$. For low and high Eu²⁺ concentrations, the strongest XRD peak is at about 27.58° and 31.91°, respectively. Energy dispersive spectra (EDS) of Ca_{1-x}Eu_xSi₂O_{2- δ}N_{2+2 δ /3} are measured. The O/N ratios are listed in table 1. It is clearly observed that the O/N ratio increases from 0.54 to 1.43 with an increase in the Eu²⁺ concentration from 0 to 0.25. Therefore, the position changes of the strongest XRD peak may be due to the effect of the increased O/N ratios. A similar effect was also observed in SrSi₂O_{2- δ}N_{2+2 δ /3} as the O/N ratio was increased [16].

3.2. The diffuse reflectance spectra

Figure 2 shows the diffuse reflectance spectra of $CaSi_2O_{2-\delta}$ $N_{2+2\delta/3}$ and Eu^{2+} -doped $CaSi_2O_{2-\delta}N_{2+2\delta/3}$. The daylight colour of the undoped $CaSi_2O_{2-\delta}N_{2+2\delta/3}$ compound is greywhite, and its diffuse reflectance spectrum is almost a flowing line, which illustrates that the $CaSi_2O_{2-\delta}$ $N_{2+2\delta/3}$ compound does not have absorption. As for the doped samples, strong absorption bands are presented in the range of the UV to visible spectral region, which can be assigned to the $4f^7 \rightarrow 4f^65d^1$ transition of the Eu^{2+} ion. It is obvious that with an increase in Eu^{2+} concentration (0.005–0.25), the absorption of Eu^{2+} becomes markedly stronger and the absorption band edge shifts to the longer wavelength side so that the body colour of the phosphors reddens gradually.

3.3. PLE and PL spectra

Figure 3 shows the PLE and PL spectra of $Ca_{1-x}Eu_xSi_2O_{2-\delta}$ $N_{2+2\delta/3}$ (x = 0.005-0.25) phosphors with different Eu^{2+} concentrations. The PLE spectrum lies in the UV to blue spectral region, which is attributed to the $4f^7 \rightarrow 4f^65d^1$ transition of Eu^{2+} . With increasing Eu^{2+} concentrations, the PLE band edge shifts to the longer wavelength side, following the formation of a strong excitation band at around 460 nm, which matches the blue LED chip very well. This band

Table 1. The mole ratios of O to N in $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ ($x = 0-0.25$)							
At %	x = 0	x = 0.005	x = 0.01	x = 0.04	x = 0.08	x = 0.15	x = 0.25
O/N	0.54	0.69	1.03	1.25	1.03	1.26	1.43

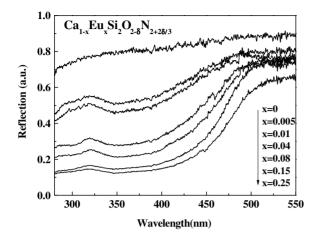


Figure 2. Diffuse reflectance spectra of $CaSi_2O_{2-\delta}N_{2+2\delta/3}$ and $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.005-0.25).

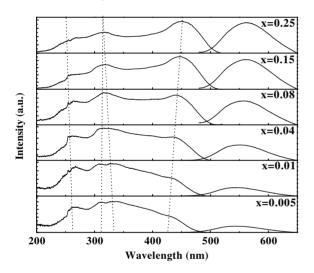


Figure 3. The excitation and emission spectra (λ_{exc} = 460 nm) of Ca_{1-x}Eu_xSi₂O_{2- δ}N_{2+2 δ /3} (*x* = 0.005–0.25).

becomes stronger with an increase in Eu^{2+} concentrations. A similar result has been reported in $Sr_{2-y}Eu_yAl_{1.6}Si_{1.4}O_{6.6}N_{0.4}$ by Li [19].

The PL spectrum for 460 nm excitation shows a single broad yellow band, which also shifts to the longer wavelength side from 543 to 562 nm with increasing Eu²⁺ concentrations from 0.005 to 0.25, and the full-width half-maximum (FWHM) is about 63 nm. The emission band is ascribed to the $4f^{6}5d^{1} \rightarrow$ $4f^{7}$ transition of divalent europium [18], and the broadness of the emission band indicates a strong interaction between the host and the activators [20]. In the PLE spectrum, there are three other PLE peaks located at about 266 nm, 310 nm and 331 nm, respectively. The 266 nm and 331 nm peaks shift to the blue side and the 310 nm peak shifts to the red side with increasing Eu²⁺ concentrations, and both the 310 nm and the 331 nm peaks shift to 315 nm for high Eu²⁺ concentrations.

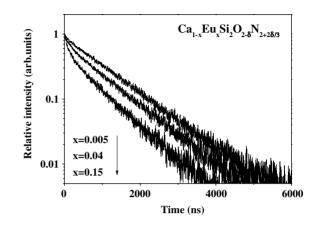


Figure 4. Fluorescence lifetimes of $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (*x* = 0.005, 0.04, and 0.15).

The redshift of the PLE band edge exhibits an increase in the energy separation between the band edge and the three other peaks, clearly demonstrating an enhanced splitting of the low-lying $4f^{6}5d^{1}$ state of Eu^{2+} , as shown in figure 3. The increased splitting implies the enhanced crystal field strength due to the modified local structure of Eu-(O, N) by increasing the O/N ratio at high Eu^{2+} concentrations. The increased splitting then leads to a redshift of emission and excitation spectra as well as the formation of the 460 nm PLE band [19].

3.4. Fluorescence lifetimes

Figure 4 shows the fluorescence decay curves with normalized initial intensities in $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.005, 0.04 and 0.15) monitored at 530 nm. By integrating the area under the decay curves, the fluorescence lifetimes are obtained. The lifetimes decrease with an increase in the dopant ions in the host matrix, and the decay curves show a single exponential behaviour for low Eu^{2+} concentrations (x < 0.04), but nonexponential behaviour for high Eu^{2+} concentrations (x = 0.15). The phenomena are the well-known effect of energy transfer among Eu^{2+} ions, in which transfer rates are not constant but have a distribution [21].

3.5. Dependence of PL intensities on Eu^{2+} concentrations

Figure 5(a) shows the dependence of luminescent intensities under 460 nm excitation and fluorescent lifetimes on Eu²⁺ concentrations. The luminescent intensities reach the maximum at x = 0.08 and tend to be saturated as x is higher than 0.08. The luminescent lifetime monotonically decreases with increasing Eu²⁺ concentrations. The lifetimes can reflect the emission efficiencies because they are obtained by integrating the area under the decay curves. The luminescent intensities (*I*) are, therefore, proportional to luminescent lifetimes (τ) and obviously also to the absorbed photon

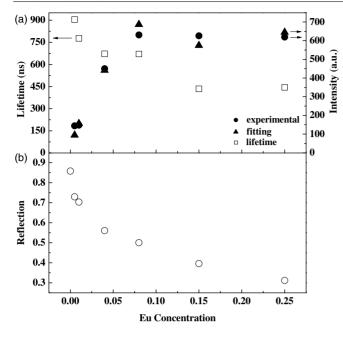


Figure 5. Luminescence intensity, lifetime (*a*) and diffuse reflectance (*b*) of $Ca_{1-x}Eu_x Si_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.005-0.25) measured at room temperature as a function of Eu^{2+} concentration.

numbers (*n*) of excitation light. *n* is proportional to the term of $1 - \exp(-x/x_c)$, where x_c is a critical Eu²⁺ concentration for absorption saturation. Then, luminescent intensity can be written as $I = A[1 - \exp(-x/x_c)]\tau$ with a constant *A*. Using this equation and the measured lifetimes to fit the measured luminescent intensities for various *x*, the value of x_c is obtained to be about 0.07. The good fitting results are presented in figure 5(*a*).

Figure 5(*b*) shows the diffuse reflectance at 460 nm as a function of Eu^{2+} concentrations. The reflectance tends to saturation as *x* is higher than 0.08, indeed indicating the performance of absorption saturation for *x* higher than x_c , as estimated above.

3.6. A white LED using a blue GaN chip and $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.15) phosphor

In order to investigate the luminescent properties of the phosphor in white LED, a white LED is fabricated by combination of a blue GaN chip and the prepared $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.15) phosphor. Figure 6 shows the electroluminescent spectrum of the as-fabricated white LED at forward-bias current $I_F = 20$ mA. Two distinct emission bands in blue and yellow are clearly observed in the emission spectrum of the PC-LED. They are from the blue LED chip and the phosphor, respectively. The generated white light shows CIE chromaticity coordinates of (0.3396, 0.3474), the correlated colour temperature (T_c) of 5223 K, the colour rendering index (CRI) of 74 and luminous efficacies of 20 lm W⁻¹.

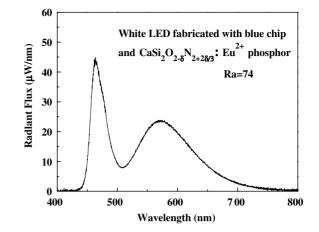


Figure 6. The electroluminescence spectra of the fabricated pc-LED combined with $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.005-0.25) phosphor under 20 mA forward-bias current.

4. Conclusions

In summary, we have synthesized a yellow emitting $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ (x = 0.005–0.25) phosphor by hightemperature solid-state reaction for creating daylight emission from PC-LED. The phosphor emits a yellow broadband in the range 543-562 nm, with FWHM of about 63 nm. The PL intensity of $Ca_{1-x}Eu_xSi_2O_{2-\delta}N_{2+2\delta/3}$ is found to be saturated This is attributed to the saturation of for $x \ge 0.08$. absorption of excitation light, which is supported by the diffuse reflectance spectra and Eu²⁺ concentrations dependent PL intensities. With an increase in Eu²⁺ concentrations, the O/N ratio increases, and the splitting of the low-lying 4f⁶5d states of Eu^{2+} is enhanced, with the result that the tail of the excitation spectrum shifts to the longer wavelength, and an additional excitation band appears at around 460 nm, perfectly matching the emission wavelength of blue LEDs. A white light-emitting LED is fabricated by a combination of a blue GaN chip and the prepared Ca_{0.85}Eu_{0.15}Si₂O_{2- δ}N_{2+2 δ /3}. The white LED exhibits CIE chromaticity coordinates of (0.3396, 0.3474), the correlated colour temperature (T_c) of 5223 K, the CRI of 74 and luminous efficacies of $20 \,\mathrm{lm}\,\mathrm{W}^{-1}$. The outstanding luminescent properties and high thermal stability indicate that further development of the $CaSi_2O_{2-\delta}N_{2+2\delta/3}$: Eu²⁺ phosphor could be an attractive topic for white LEDs.

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